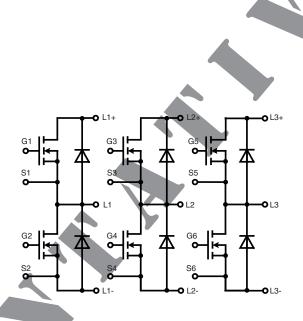


Three phase full Bridge

with Trench MOSFETs in DCB-isolated high-current package

= 55 V V_{DSS} = 150 A $R_{DSon typ.} = 2.2 \text{ m}\Omega$

Part number MTC120WX55GD



Features / Advantages:

- MOSFETs in trench technology:
 - low $R_{\mbox{\scriptsize DSon}}$
 - optimized intrinsic reverse diode
- Package:
 - high level of integration
 - high current capability
 - aux. terminals for MOSFET control
 - terminals for soldering or welding connections
 - isolated DCB ceramic base plate with optimized heat transfer
- · Space and weight savings

Applications:

AC drives

- · in automobiles
 - electric power steering
 - starter generator
- · in industrial vehicles
 - propulsion drives
 - fork lift drives
- · in battery supplied equipment

Package: ISOPLUS-DIL®

- · High level of integration
- · RoHS compliant
- · High current capability
- Aux. Terminals for MOSFET control
- Terminals for soldering or welding connections
- · Space and weight savings

Terms & Conditions of usage

The data contained in this product data sheet is exclusively intended for technically trained staff. The user will have to evaluate the suitability of the product for the intended application and the completeness of the product data with respect to his application. The specifications of our components may not be considered as an assurance of component characteristics. The information in the valid application- and assembly notes must be considered. Should you require product information in excess of the data given in this product data sheet or which concerns the specific application of your product, please contact your local sales office.

Due to technical requirements our product may contain dangerous substances. For information on the types in question please contact your local sales office.

Should you intend to use the product in aviation, in health or life endangering or life support applications, please notify. For any such application we urgently recommend

- to establish joint measures of an ongoing product survey, and that we may make delivery dependent on the realization of any such measures.

IXYS reserves the right to change limits, test conditions and dimensions.

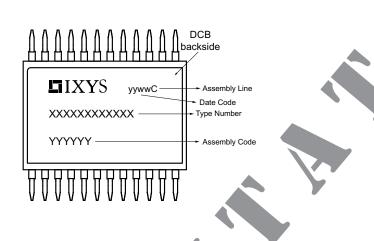
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MOSFET	·s			Ratir	ngs	
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V _{DSS}	drain source breakdown voltage	$T_{VJ} = 25^{\circ}C$ to 150)°C		55	V
\mathbf{V}_{GS} \mathbf{V}_{GSM}	gate source voltage max. transient gate source voltage				±15 ±20	V V
I _{D25} I _{D80} I _{D100}	continuous drain current	$T_{c} = 25$ $T_{c} = 80$ $T_{c} = 100$	°C		150 120 106	A A A
R _{DS(on)} 1)	static drain source on resistance	on chip level at $T_{VJ} = 25$ $I_D = 100 \text{ A}; V_{GS} = 10 \text{ V}$ $T_{VJ} = 125$		2.2 3.7	3.1 5.3	mΩ mΩ
$V_{\rm GS(th)}$	gate threshold voltage	$I_{D} = 1 \text{ mA}; V_{DS} = V_{GS}$ $T_{VJ} = 25$	°C 3.0		4.0	V
I _{DSS}	drain source leakage current	$V_{DS} = V_{DSS}; V_{GS} = 0 V$ $T_{VJ} = 25$ $T_{VJ} = 125$		50	1	μ Α μ Α
I _{GSS}	gate source leakage current	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0 \text{ V}$			500	nA
\mathbf{R}_{G}	gate resistance	on chip level				Ω
$egin{array}{c} C_{iss} \ C_{oss} \ C_{rss} \end{array}$	input capacitance output capacitance reverse transfer capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ Mhz}$		6.97 1.03 230		nF nF pF
$egin{array}{l} \mathbf{Q}_{g} \ \mathbf{Q}_{gs} \ \mathbf{Q}_{gd} \end{array}$	total gate charge gate source charge gate drain (Miller) charge	$V_{GS} = 10 \text{ V}; V_{DS} = 28 \text{ V}; I_D = 100 \text{ A}$		100 35 25		nC nC nC
$t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f}$	turn-on delay time current rise time turn-off delay time current fall time	inductive load $T_{VJ} = 125$ $V_{GS} = 10 \text{ V}; V_{DS} = 24 \text{ V}$	°C	100 110 500 100		ns ns ns ns
E _{on} E _{off} E _{rec(off)}	turn-on energy per pulse turn-off energy per pulse turn-off reverse recovery losses	$I_D = 100 \text{ A}; H_G = 39 \Omega$		0.12 0.53 0.01		mJ mJ mJ
R_{thJC}	thermal resistance junction to case				1.0	K/W
R_{thJH}	thermal resistance junction to heatsink	with heat transfer paste (IXYS test setup)		1.3		K/W
	4	¹⁾ $V_{DS} = I_D \cdot (R_{DS(on)} + 2 \cdot R_{Pin \text{ to Chip}})$				
Source-E	Drain Diode					
_{F25} _{F80} _{F100}	forward current	$V_{GS} = 0 V$ $T_{C} = 25$ $T_{C} = 80$ $T_{C} = 100$	°C		140 95 80	A A A
$\mathbf{V}_{\mathtt{SD}}$	source drain voltage	$I_F = 100 \text{ A}; V_{GS} = 0 \text{ V}$ $T_{VJ} = 25$	°C	0.9	1.2	V
Q _{RM} I _{RM} t _{rr}	reverse recovery charge max. reverse recovery current reverse recovery time	$V_R = 24 \text{ V}; I_F = 100 \text{ A}$ $di/dt = 800 \text{ A/}\mu\text{s}$ $T_{VJ} = 125$	°C	0.45 22 38		μC A ns



Package	Package ISOPLUS-DIL®					Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit			
I _{RMS}	RMS current	per pin in main current paths (L1+L3+, L1L3-, L1L3) may be additionally limited by external connections (PCB tracks) 2 pins for output L1, L2, L3			75	А			
T _{stg}	storage temperature		-55		125	°C			
T _{VJM}	virtual junction temperature		-55		175	°C			
Weight				25		g			
F _c	mounting force with clip	4	50		250	N			
V _{ISOL}	isolation voltage	t = 1 second	1200			V			
		$\frac{t = 1 \text{ second}}{t = 1 \text{ minute}} = 50/60 \text{ Hz, RMS, } I_{ISOL} \le 1 \text{ mA}$	1000			V			
R _{pin-chip}	resistance terminal to chip	$V_{DS} = I_{D} \cdot (R_{DS(on)} + 2 \cdot R_{pin \text{ to chip}})$		0.5		$m\Omega$			
C _P	coupling capacity	between shorted pins and back side metallization		160		pF			



Part number

M = MOSFET

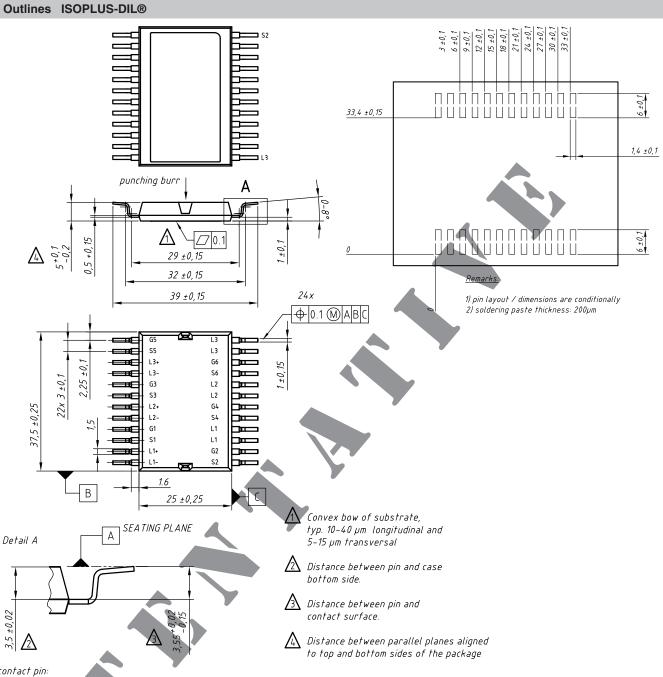
= Trench

C = Trench 2nd Generation

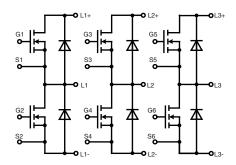
120 = Current Rating [A]
WX = 6-Pack with separated Phase Legs
55 = Reverse Voltage [V]
GD = ISOPLUS-DIL

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	MTC120WX55GD-SMD	MTC120WX55GD	Tube	13	517108





- contact pin:
- galv. tin plating, per pin side: Sn 10...25 μm, undercoating Ni 0,2...1 μm stamping edges may be free of tin puching burr: ≤ 0,05mm



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